## Notice of References Cited Application/Control No. 10/589,550 Examiner MYRON WYCHE Applicant(s)/Patent Under Reexamination NO ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2007/0123311	05-2007	Kim et al.	455/567
*	В	US-2004/0120494	06-2004	Jiang et al.	379/210.01
*	С	US-6,768,789	07-2004	Wilk, Daniel	379/67.1
*	D	US-2002/0193125	12-2002	Smith, Bryan	455/458
*	Е	US-2004/0203613	10-2004	Zhu et al.	455/412.1
*	F	US-2005/0096006	05-2005	Chen et al.	455/400
*	G	US-7,509,149	03-2009	Shim et al.	455/567
	Н	US-		j =	
	ı	US-	6		
	J	US-		-	
	K	US-	<b>1</b>		
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0					
	Р					
	Q					
6	R					
	s					
					100	

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U							
	V							
	w							
	х							

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.